

Tera Probe Announces establishment of "Test Center" in Kyushu Operation Center

Yokohama, Japan - Tera Probe, Inc. ("Tera Probe"), today announces that we will establish a "Test Center" with the cutting edge facilities of semiconductor test fields to facilitate devices development and evaluation environment and provide a comprehensive test environment to all semiconductor devices in Kyushu Operation Center in July, 2009

The semiconductor test house business in Japan has been confined to an offer of the test ability only for the overflow part of the mass production by the customers, however our "Test Center" with advanced facilities of all semiconductor test fields is aimed to contribute to improve the efficiency of the investment and the resources of customers by offering services from the stage of device development and an evaluation.

"Test Center" will be equipped with leading edge testers and probers of various semiconductor devices such as SoC, Sensor, Analog, Flash microcomputer, and Memory. We will also cover wide range of test field by proving technical support from test program to mass production setup. In addition, we will offer environment where the customers can operate testers and probers directly from the desk of the customer by the remote access which will be guarded with the security system.

We understand that a shift from the business model of vertical integration type currently prevailing in the semiconductor industry in Japan to the business model of horizontal specialization type to specialize in each field of the semiconductor manufacturing process would contribute to the reinforcement of the competitive power of the Japanese semiconductor industry.

We believe the Test Center will become the help of the shift to the horizontal division of labor type, and it will enable the customers to realize the reduction of the investment risk in the test process and the concentration of resources to the customer's specialties. And we believe that we can contribute to realization of the effective practical usage of the device development resources, development power reinforcement, and the short term time-to-market at the customer side.

Tera Probe that has pursued technology of the world top-level always with an eye to the most advanced semiconductor test will continuously offer the most suitable test service that will meet the needs of the customer in pursuit of the high efficiency, low cost, and high reliability.

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